


<b>Search Notes</b>  	<b>Application/Control No.</b>  10585642	<b>Applicant(s)/Patent Under Reexamination</b>  YANO ET AL.
	<b>Examiner</b>  Rachel L Burney	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
430	48, 108.2	6/3/2010	RLB
528	361	6/3/2010	RLB
399	130, 50	6/3/2010	RLB
430	111.32, 111.35	12/01/2010	RLZ

SEARCH NOTES		
Search Notes	Date	Examiner
inventorship search	6/3/2010	RLB
text searc in EAST (see search history)h	6/3/2010	RLB
consulted with SPE Mark Huff	6/3/2010	RLB
updated text search in EAST (see search history)	12/01/2010	RLZ
consulted with Chris RoDee	12/01/2010	RLZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/R. L. Z./ Examiner.Art Unit 1721	
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